Sheet Application No. 09/840,003

TECHNOLOGY
Art Unkelvier 1600/200 Substitute Form PTO-1449 Attorney's Docket No. U.S. Department of Commerce Patent and Trademark Office (MpdFleet) 10555-022001 Information Disclosur Statement **Applicant** Marco Falcioni, et al. by Applicant (Use several sheets if necessary) Filing Date April 19, 2001 **U.S. Patent Documents** Publication Desig. Filing Date **Examiner Document**

Patentee

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Other Documents (include Author, Title, Date, and Place of Publication)					
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mes	AE	HD. Klein, "Statistische Versuchsplanung", 1995, Nachr. Chem. Tech. Lab. Vol. 43, pp. 1078, 1080-1082 (with English translation).			
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Attorney's Docket No. 10555-022001

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Applicant Marco Falcioni, et al.

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Foreign Patent Documents or Published Foreign Patent Applications							าร	-
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